Notice of References Cited

_	Application/Control No. 09/002,031	Reexaminatio	Applicant(s)/Patent Under Reexamination ADAMS ET AL.		
	Examiner	Art Unit			
	Hugh Jones	2128	Page 1 of 1		

U.S. PATENT DOCUMENTS

	O.S. FATENT DOCUMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

	NON-I ATENT DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	٦	Tylka et al.; CREME96: a revision of the Cosmic Ray Effects on Microelectronics code; IEEE Trans. Nuclear Science; pp. 2150-2160; 12/1997.				
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	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.